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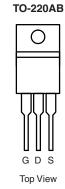
## **Power MOSFET**

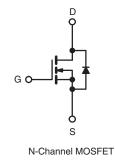
PRODUCT SUMMARY					
V <sub>DS</sub> (V)	600				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V 1.2				
Q <sub>g</sub> (Max.) (nC)	39				
Q <sub>gs</sub> (nC)	10				
Q <sub>gd</sub> (nC)	19				
Configuration	Single				

#### **FEATURES**

- Ultra Low Gate Charge
- Reduced Gate Drive Requirement
- Enhanced 30 V, V<sub>GS</sub> Rating
- Reduced C<sub>iss</sub>, C<sub>oss</sub>, C<sub>rss</sub>
- Extremely High Frequency Operation
- Repetitive Avalanche Rated
- Compliant to RoHS Directive 2002/95/EC







<b>ABSOLUTE MAXIMUM RATINGS (T</b> <sub>C</sub>	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	600	- V	
Gate-Source Voltage			V <sub>GS</sub>	± 30		
Continuous Drain Current	V <sub>GS</sub> at 10 V	$T_{C} = 25 \degree C$ $T_{C} = 100 \degree C$		4		
	VGS at TO V	$T_C = 100 ^{\circ}C$	ID	2.9	A	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	25		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	530	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	6.2	А	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	13	mJ	
Maximum Power Dissipation $T_{C} = 25 \text{ °C}$			PD	125	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	3.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) for 10 s			300 <sup>d</sup>			
Mounting Torque	6.32 or M	6.00 or M2 corrow		10	lbf ∙ in	
Mounting Torque	6-32 or M3 screw			1.1	N · m	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = 50 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ , L = 25 mH,  $R_g = 25 \Omega$ ,  $I_{AS} = 6.2 \text{ A}$  (see fig. 12). c.  $I_{SD} \le 6.2 \text{ A}$ , dI/dt  $\le 80 \text{ A/}\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150 \text{ °C}$ .

d. 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

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THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62			
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	1.0			

SPECIFICATIONS (T <sub>J</sub> = 25 °C, u	nless otherw	ise noted)					
PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0$	V, I <sub>D</sub> = 250 μA	600	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I <sub>D</sub> = 1 mA	-	0.70	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V$	<sub>GS</sub> , I <sub>D</sub> = 250 μΑ	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V	$V_{GS} = \pm 20$		-	± 100	nA
Zero Gate Voltage Drain Current	$V_{DS} = 600 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		00 V, V <sub>GS</sub> = 0 V	-	-	- 100	
Zero Gale Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 480 V, \	/ <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	500	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 V$	I <sub>D</sub> = 3.7 A <sup>b</sup>	-	-	1.2	Ω
Forward Transconductance	<b>g</b> <sub>fs</sub>	V <sub>DS</sub> = 10	00 V, I <sub>D</sub> = 3.7 A <sup>b</sup>	3.7	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V		-	1100	-	
Output Capacitance	C <sub>oss</sub>	V	<sub>DS</sub> = 25 V	I	140	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0	MHz, see fig. 5	I	15	-	
Total Gate Charge	Qg			-	-	39	
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 V$	$V_{GS} = 10 \text{ V}$ $I_D = 4 \text{ A}, \text{ V}_{DS} = 360 \text{ V},$ see fig. 6 and $13^{\text{b}}$		-	10	nC
Gate-Drain Charge	Q <sub>gd</sub>				-	19	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = 300 V, $I_D$ = 4 A $R_g$ = 9.1 $\Omega,R_D$ = 47 $\Omega,$ see fig. $10^b$		-	12	-	- ns
Rise Time	t <sub>r</sub>			-	20	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	27	-	
Fall Time	t <sub>f</sub>			-	17	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L <sub>S</sub>			-	7.5	-	nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	4.0	А
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	25	
Body Diode Voltage	V <sub>SD</sub>	$T_J = 25 \ ^{\circ}C, I_S = 4 \ A, V \ _{GS} = 0 \ V^b$		-	-	1.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25$ °C, $I_F = 4$ A, dl/dt = 100 A/µs b		-	440	680	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	2.1	3.2	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )					L <sub>D</sub> )

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq 300~\mu s;$  duty cycle  $\leq 2~\%.$ 

### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

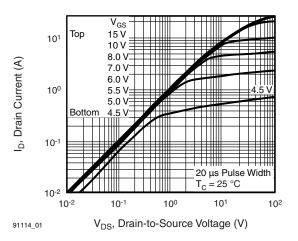


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

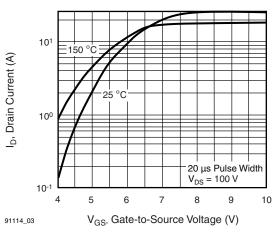


Fig. 3 - Typical Transfer Characteristics

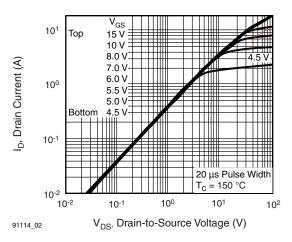


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 150 °C

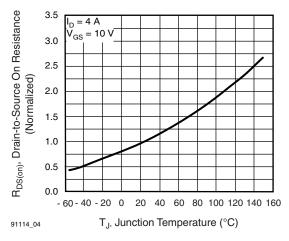


Fig. 4 - Normalized On-Resistance vs. Temperature

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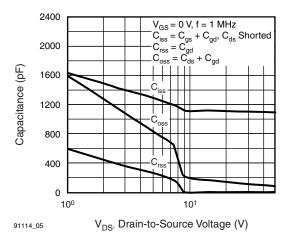


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

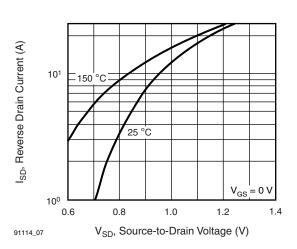


Fig. 7 - Typical Source-Drain Diode Forward Voltage

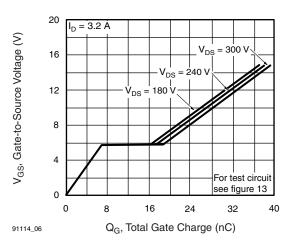


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

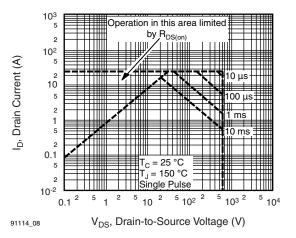


Fig. 8 - Maximum Safe Operating Area

DFB&@("!6FG&@("

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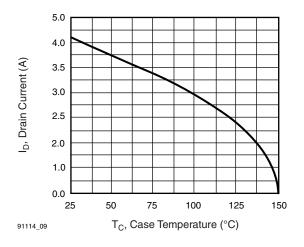


Fig. 9 - Maximum Drain Current vs. Case Temperature

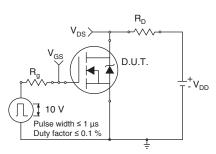


Fig. 10a - Switching Time Test Circuit

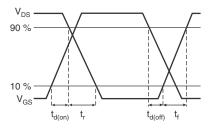


Fig. 10b - Switching Time Waveforms

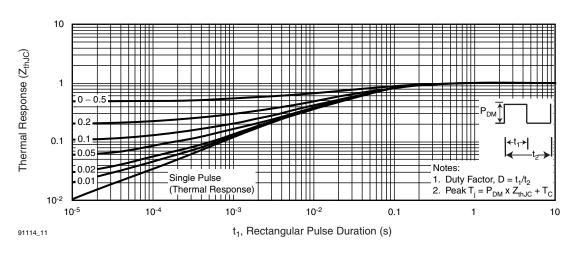


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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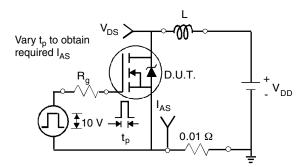


Fig. 12a - Unclamped Inductive Test Circuit

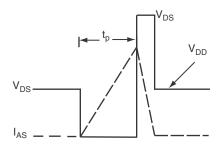


Fig. 12b - Unclamped Inductive Waveforms

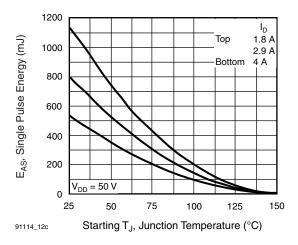


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

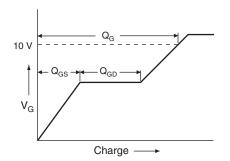


Fig. 13a - Basic Gate Charge Waveform

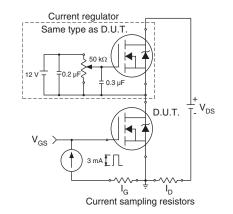
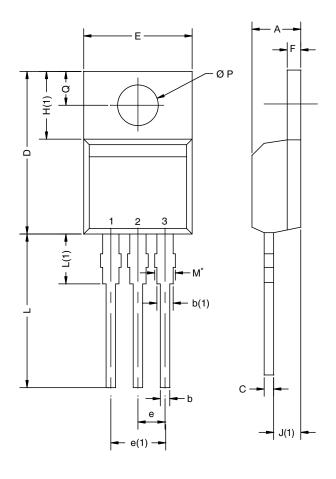


Fig. 13b - Gate Charge Test Circuit



## **TO-220AB**

	MILLIMETERS		INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
с	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
E	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØР	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471					

#### Notes

\* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM

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